

Search Notes

Application/Control No.

10/662,325

Examiner

Y Quach Lee

Applicant(s)/Patent under
Reexamination

KOIKE, TERUO

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	237 240 241 243 247 538 539 543 544 545	3/8/2005	YMY
	800		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	3/8/2005	YMY